

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>		Application No.	10/582,588
(Multiple sheets used when necessary)		Filing Date	June 09, 2006
SHEET 1 OF 2		First Named Inventor	James S. Williams et al.
		Art Unit	Unknown 2827
		Examiner	Unknown C. Yoha
		Attorney Docket No.	DAVI258.003APC

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<b>U.S. PATENT DOCUMENTS</b>				
Examiner Initials Inventor Initials	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
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<b>FOREIGN PATENT DOCUMENTS</b>						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T <sup>1</sup>
10	CN 1442853	09-17-2003	Horie Michikazu			
11	EP 1343154	10-25-2006	Horie Michikazu et al.			
12	EP 1371062	02-22-2006	Gerd K. Binnig et al.			
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16	WO 2002/077988	10-03-2002	Gerd K. Binnig et al.			
17	WO 2003/098664	11-27-2003	Jeffrey Peterson et al.			

<b>NON PATENT LITERATURE DOCUMENTS</b>						
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				T <sup>1</sup>
18	P.Vettiger et al, <i>The "Millipede"-Nanotechnology Entering Data Storage IEEE Transactions on Nanotechnology</i> , 1(1), pp.39-55, 2002					
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Examiner Signature	/Connie Yoha/	Date Considered	02/15/2010
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T<sup>1</sup> - Place a check mark in this area when an English language Translation is attached.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /C.Y./

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	22	J.S. Williams et al, <i>Mechanical Property Characterization of Crystalline, Ion Implantation Amorphised and Annealed Relaxed Silicon with Spherical Indenters</i> Pro. Material Research Society Symposium. 308, pp.571-6,1993	
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